

TS-00-415



May 19, 2004

GP 2133
AF
61

To: Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Fr: George O. Saile, Reg. No. 19,572
28 Davis Ave
Poughkeepsie, NY 12603

Subject: | Serial No. 09/883,449 06/18/01 |
| Nai-Yin Sung
"A METHOD TO VERIFY THE PERFORMANCE
OF BIST CIRCUITRY FOR TESTING
EMBEDDED MEMORY"
Grp. Art Unit: 2133 J. TRIMMINGS

RESPONSE PATENT OFFICE ACTION

Dear Sir:

In response to the Office Action dated March 19, 2004,
please amend the above-identified application for patent as
follows:

RECEIVED

JUN 29 2004

Technology Center 2100

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being
deposited with the United States Postal Service as first class
mail in an envelope addressed to: Commissioner for Patents, P.O.
Box 1450, Alexandria, VA 22313-1450, on June 21, 2004.

Stephen B. Ackerman, Reg. No. 37,761

Signature

Date

SB
6/21/04